

On the Geometric Dependence of Scintillation and Stochastic Structure Models

by

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Stochastic Structure Models

- Parameterized structure models provide the interface between propagation theory and real-world observations.

Caveats:

- Highly field-aligned structures do not support definitive statistical variations along the field lines.
- Structure realizations derived by imposing an amplitude variation on uncorrelated Fourier modes are non-physical.
- This talk will introduce a configuration-space model that preserves known structure characteristics with realizable *striations*.

Two Structure Realization Approaches

Summation of Fourier components

$$\delta N(\mathbf{r})/N_0 = \iiint \sqrt{\Phi_{\delta N/N_0}(\mathbf{K})} \eta(\mathbf{K}) \exp\{i\mathbf{K} \cdot \mathbf{r}\} \frac{d\mathbf{K}}{(2\pi)^3}$$

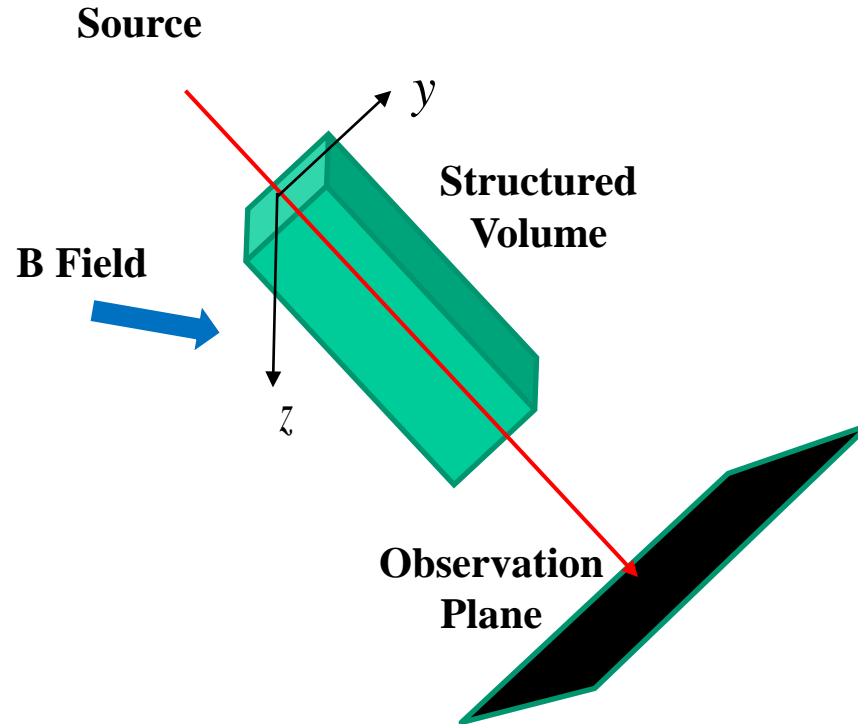
Summation of Striations

$$\delta N(\zeta_s, \zeta_\tau)/N_0 = \frac{1}{N_s} \sum_k F_k p_s(|\zeta_s - \zeta_s^k|) p_\perp(|\zeta_\tau - \zeta_\tau^k|/\sigma_k)$$

$$\delta N(\kappa_s)/N_0 = \frac{1}{N_s} \sum_k F_k \sigma_k^2 \hat{p}_\perp^{(2)}(\kappa_s \sigma_k) \exp\{-i\kappa_s \cdot \rho_s^k\}$$

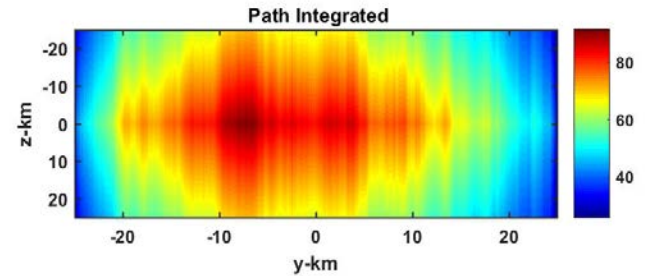
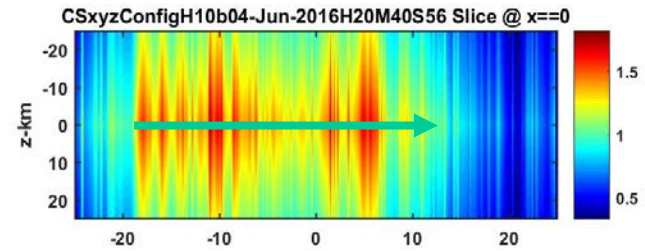
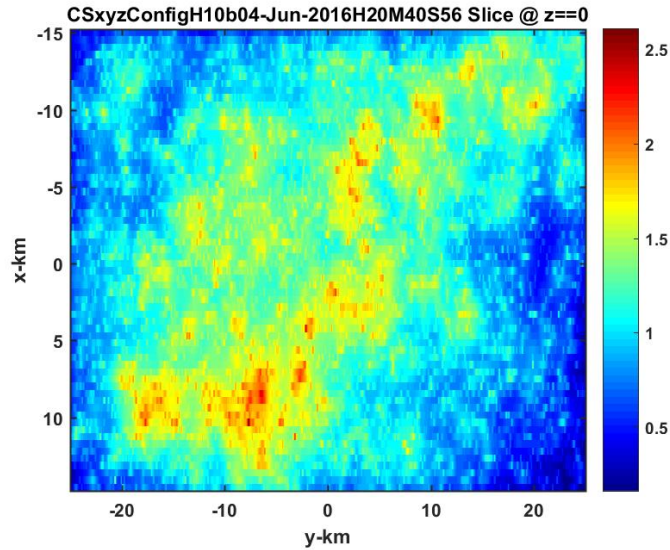
$$\langle |\Delta N(\kappa_s)|^2 \rangle / N_0^2 = \frac{1}{N_s} \sum_k F_k^2 \sigma_k \left| \hat{p}_\perp^{(n_d)}(\kappa_s \sigma_k) \right|^2 \quad n_d = \begin{cases} 1 \\ 2 \end{cases}$$

Propagation Geometry

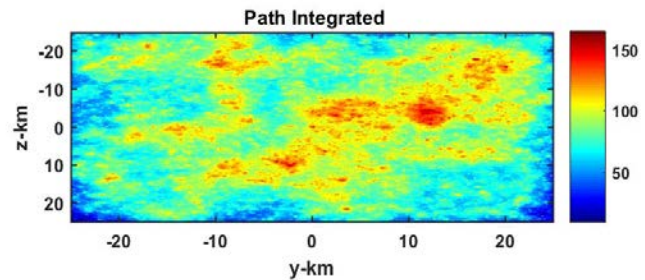
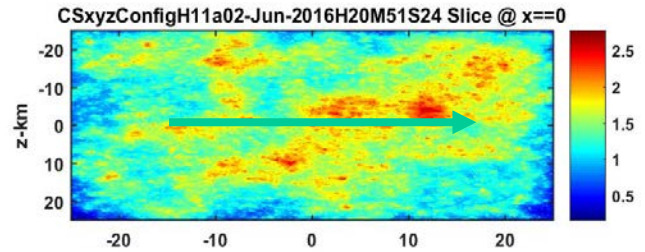
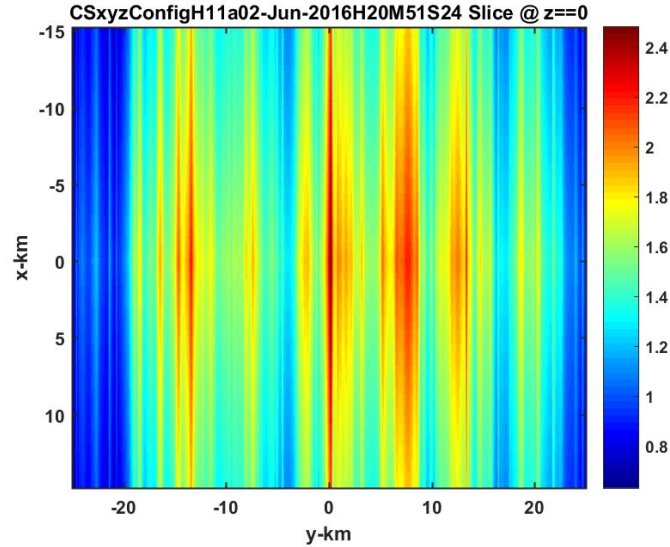


Cardinal Orientations

Cross
Field

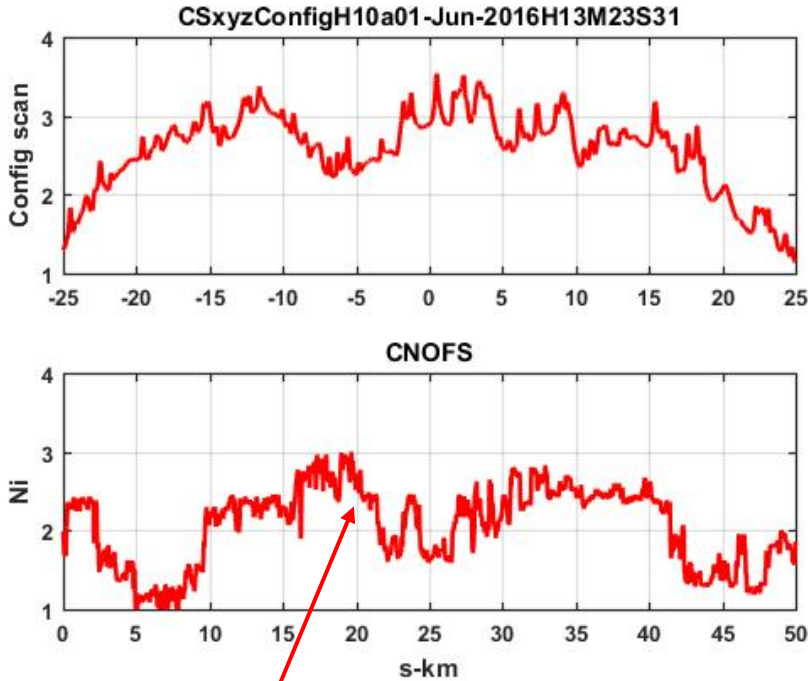
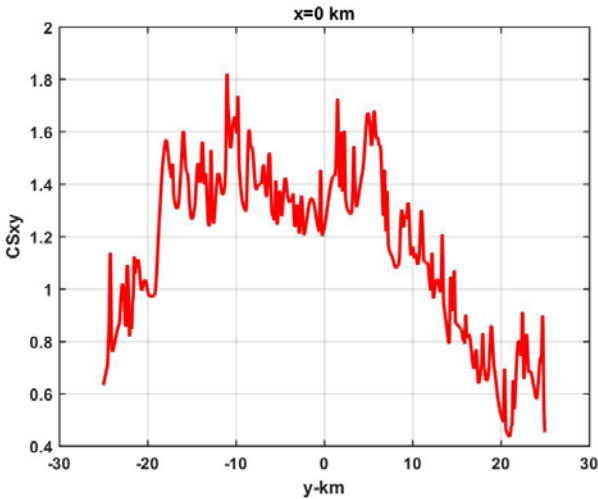


Along
Field



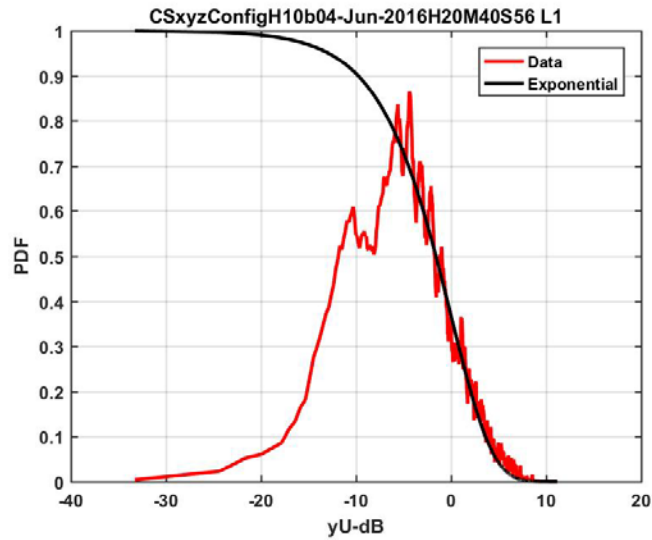
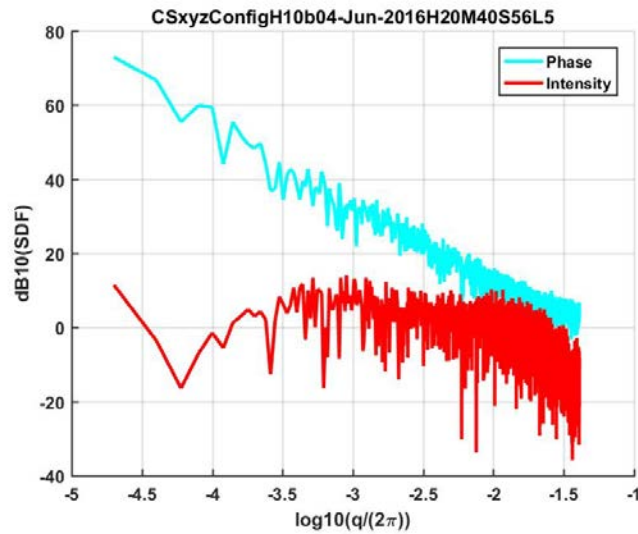
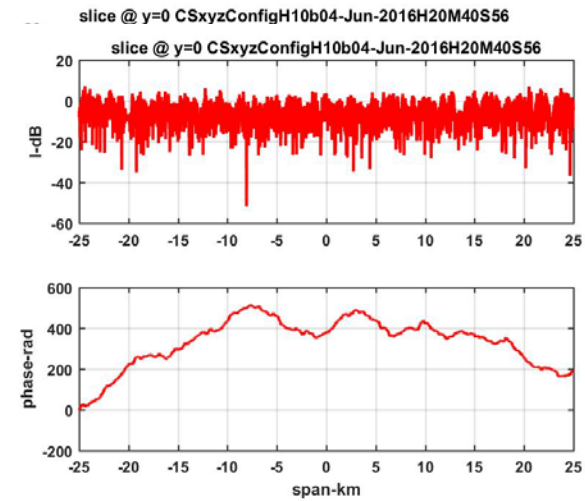
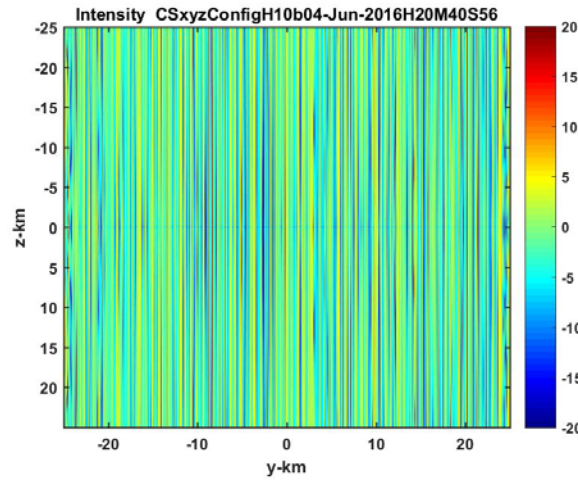
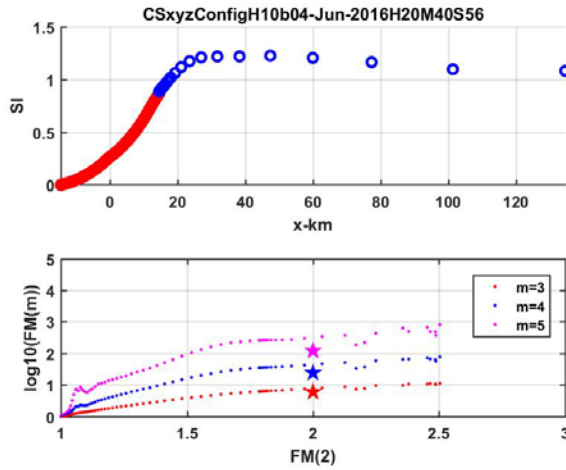
1D Cross-Field Scans

Cross
Field

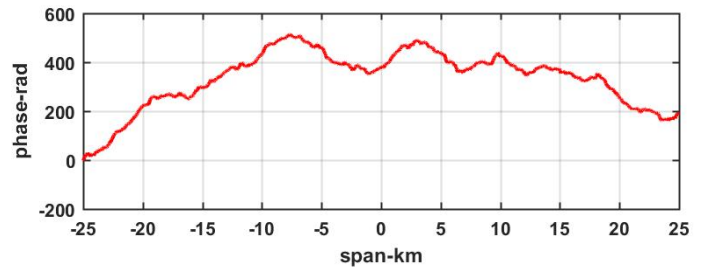
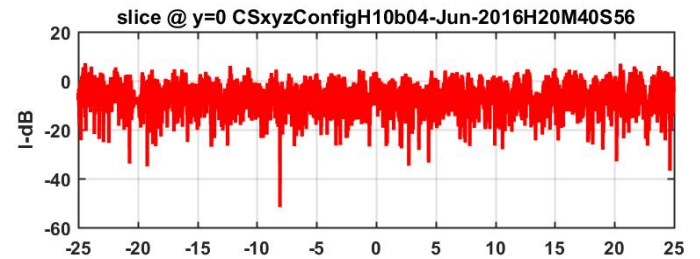
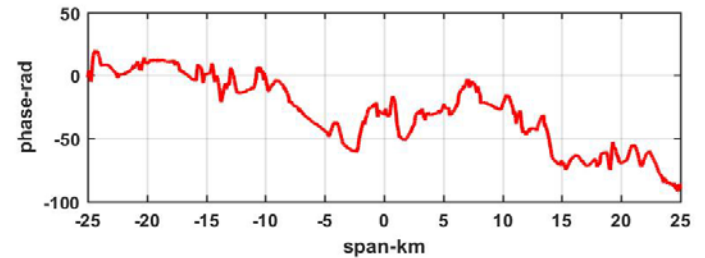
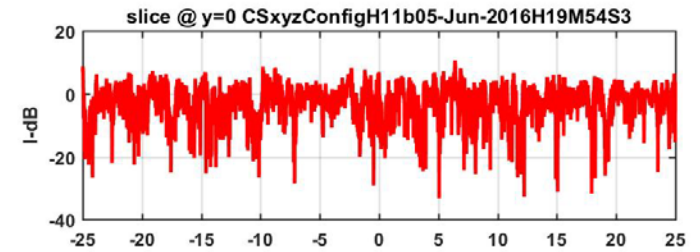
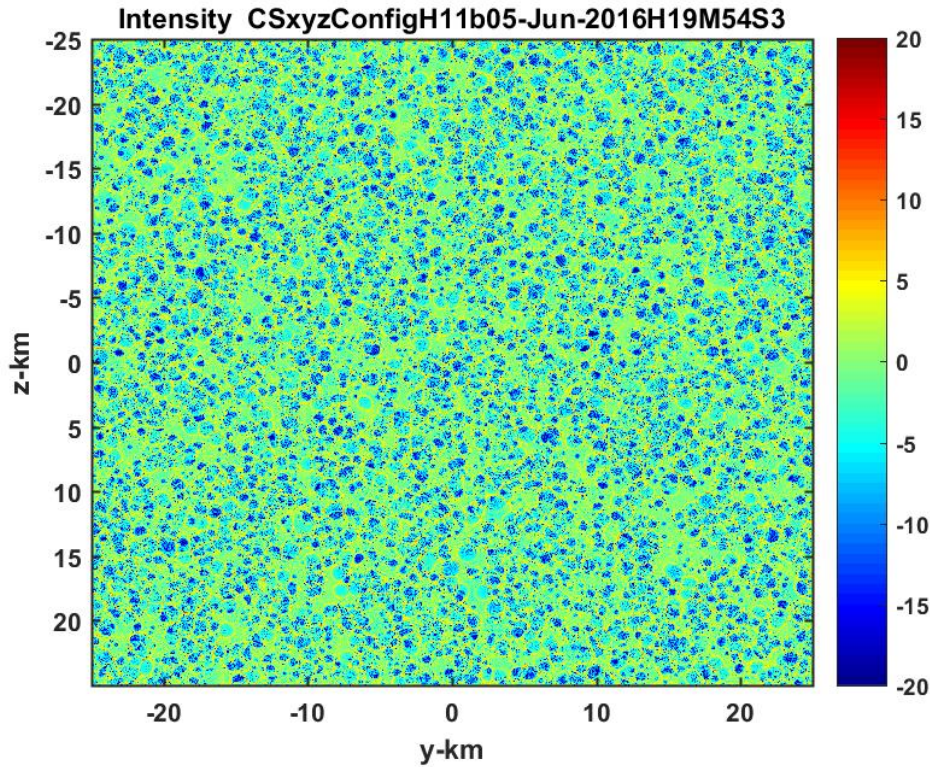


C/NOFS Data

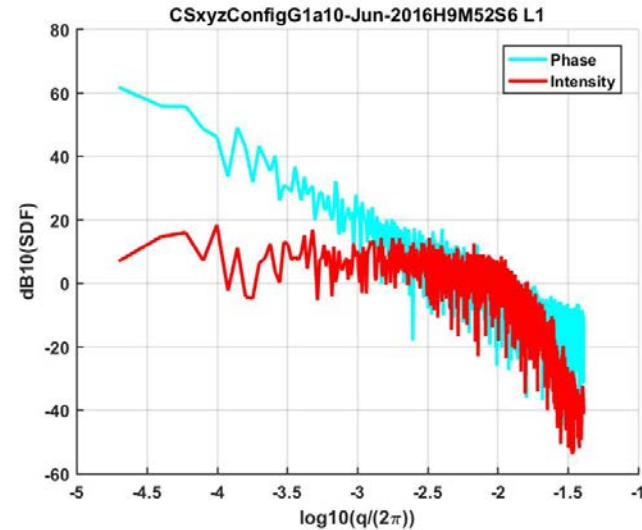
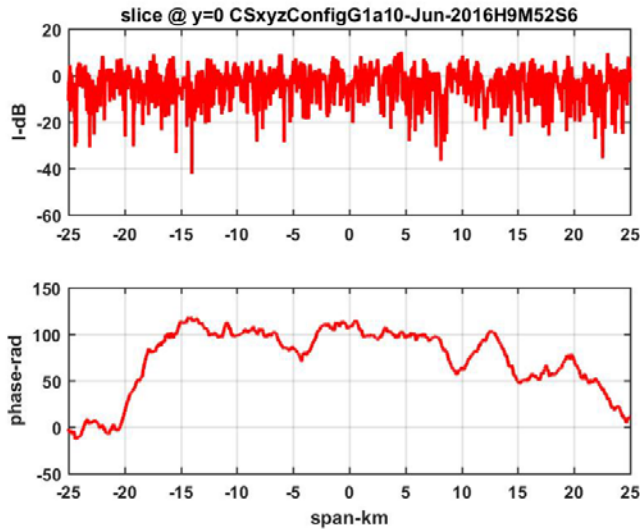
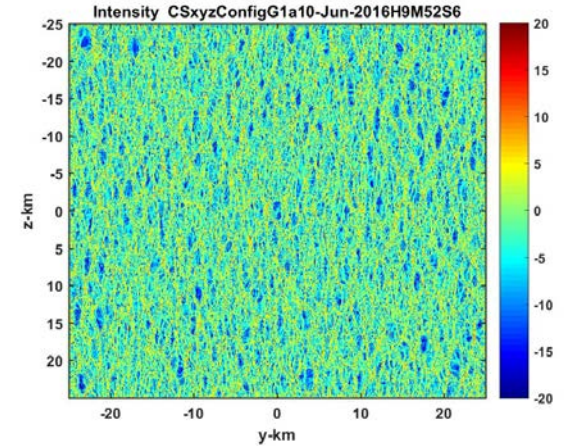
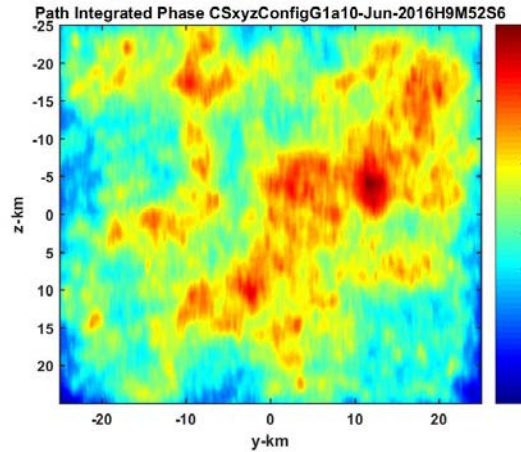
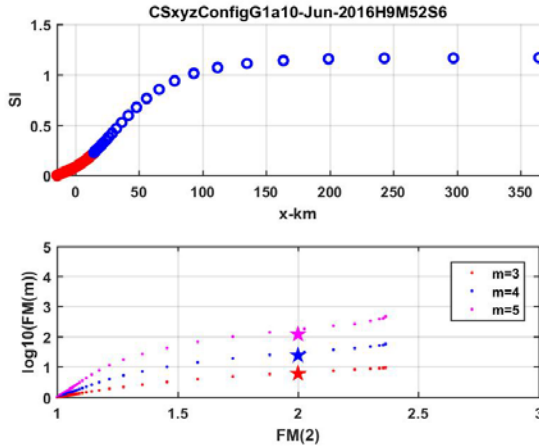
Propagation Cross Field



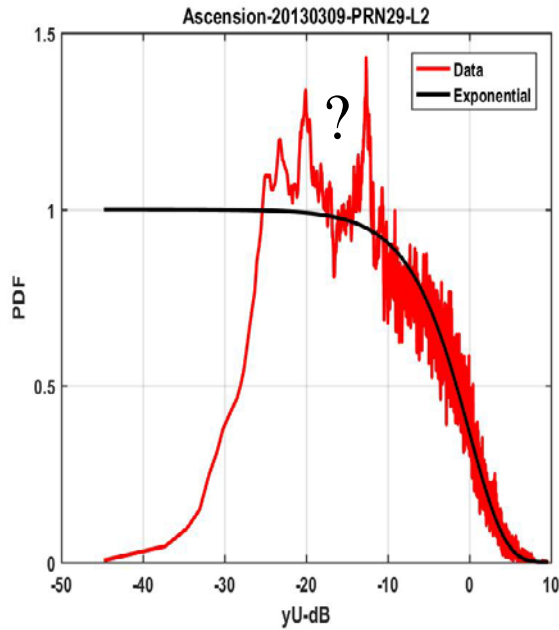
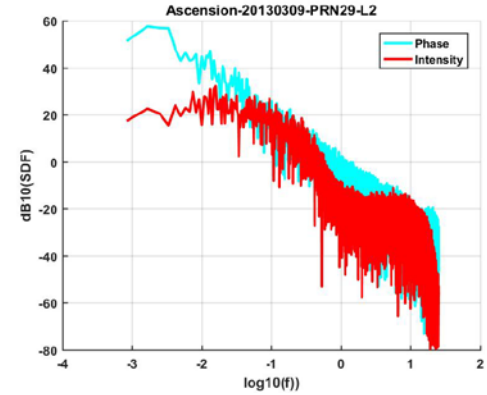
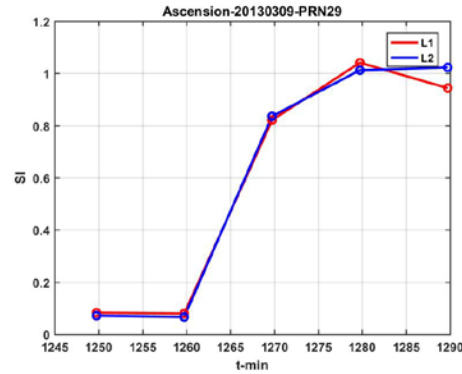
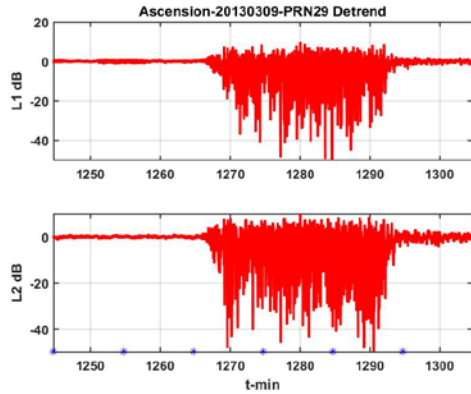
Propagation Along Field



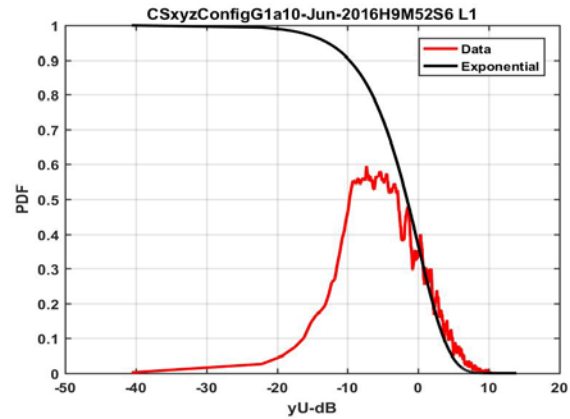
A Directed Example



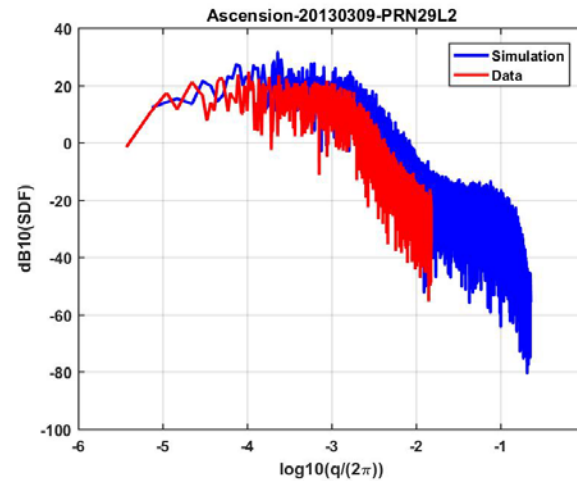
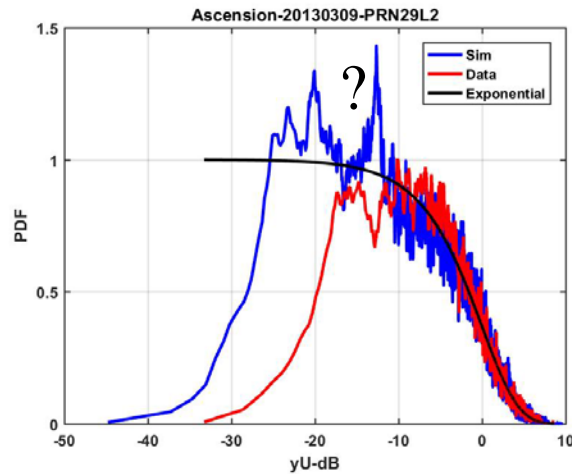
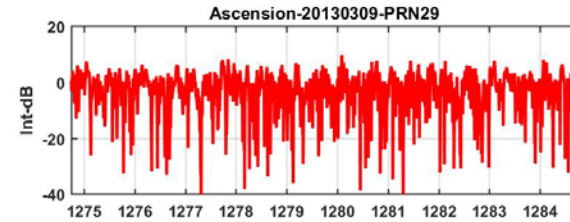
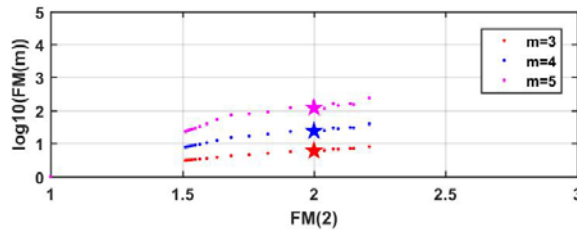
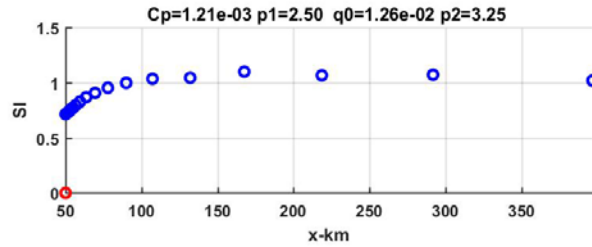
Ascension Island Data



Simulation PDF



One-Dimensional Phase Screen



Conclusions

- Cross-field and field-aligned propagation geometries generate measurement-plane structure that preserve striation size-distributions.
- Textural differences depend on field-aligned structure, which is currently being investigated.
- Fully two-dimensional or equivalent phase screens capture the stochastic structure.
- Conventional structure realizations also capture the stochastic structure.
- Structure defined by striation distributions has ramifications for data interpretation. PDFs are more sensitive to structural differences than PSDs.
- The ramification of field curvature remains to be investigated.

Successive Bifurcation Rule

$\sigma_j = \sigma_{\max} 2^{-j}$ Striation scale

$N_j = 2^{d-j}$ Number of striations at scale j

$F_j = \sigma_j^{-\eta}$ Strength of striation at scale j

